
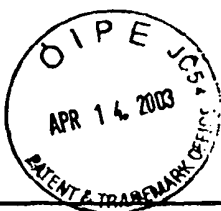


| <b>INFORMATION DISCLOSURE<br/>CITATION</b><br> <b>PTO-1449</b> |            |          | ATTY. DOCKET NO.<br>17524-728 |                                | SERIAL NO.<br>09/944,063 |                          |                          |
|---|------------|----------|-------------------------------|--------------------------------|--------------------------|--------------------------|--------------------------|
|   |            |          | APPLICANT Mitchell, et al.    |                                |                          |                          |                          |
|   |            |          | FILING DATE 8/30/01           |                                | GROUP 2878               |                          |                          |
| <b>U.S. PATENT DOCUMENTS</b>  |            |          |                               |                                |                          |                          |                          |
| EXAMINER'S<br>INITIALS  | PATENT NO. | DATE     | NAME                          | CLASS                          | SUBCLASS                 | FILING DATE              |                          |
| SL  | 4,543,479  | 9/24/85  | Kato                          | 250                            | 327.2                    |                          |                          |
| SL  | 4,582,989  | 4/15/86  | Agano                         | 250                            | 327.2                    |                          |                          |
| SL  | 4,973,134  | 11/27/90 | Finkenzeller, et al.          | 250                            | 327.2                    |                          |                          |
| SL  | 5,635,728  | 6/3/97   | Cantu, et al.                 | 250                            | 584                      |                          |                          |
| SL  | 5,801,385  | 9/1/98   | Endo, et al.                  | 250                            | 370.11                   |                          |                          |
| SL  | 5,844,242  | 12/1/98  | Jalink, Jr., et al.           | 250                            | 370.09                   |                          |                          |
| SL  | 5,988,802  | 11/23/99 | Pawlowski, Jr., et al.        | 347                            | 86                       |                          |                          |
| SL  | 6,005,911  | 12/21/99 | Cheung                        | 378                            | 37                       |                          |                          |
|   |            |          |                               |                                |                          |                          |                          |
|   |            |          |                               |                                |                          |                          |                          |
| <b>FOREIGN PATENT DOCUMENTS</b>   |            |          |                               |                                |                          |                          |                          |
| EXAMINER'S<br>INITIALS  | PATENT NO. | DATE     | COUNTRY                       | CLASS                          | SUBCLASS                 | TRANSLATION              |                          |
|   |            |          |                               |                                |                          | YES                      | NO                       |
|   |            |          |                               |                                |                          | <input type="checkbox"/> | <input type="checkbox"/> |
|   |            |          |                               |                                |                          | <input type="checkbox"/> | <input type="checkbox"/> |
| <b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b>   |            |          |                               |                                |                          |                          |                          |
|   |            |          |                               |                                |                          |                          |                          |
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| EXAMINER <i>SL</i>  |            |          |                               | DATE CONSIDERED <i>11/3/03</i> |                          |                          |                          |

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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SHEET 1 OF 1

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| <b>INFORMATION DISCLOSURE<br/>CITATION</b><br><br>PTO-1449                    |  | ATTY. DOCKET NO.<br>39315-0043 |   | SERIAL NO.<br>09/944,063 |          |                          |                          |
|   |  | APPLICANT Mitchell et al.      |   |                          |          |                          |                          |
|   |  | FILING DATE 08/30/2001         |   | GROUP 2878               |          |                          |                          |
| <b>U.S. PATENT DOCUMENTS</b>  |  |                                |   |                          |          |                          |                          |
| EXAMINER'S<br>INITIALS  | PATENT NO.   | DATE                           | NAME                                      | CLASS                    | SUBCLASS | FILING DATE              |                          |
| SE  | 4,922,103  | 5/1/90                         | Kazuhiro <del>ZB</del> et al.<br>Kawajiri | —                        | —        |                          |                          |
|   |  |                                |   |                          |          |                          |                          |
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| <b>FOREIGN PATENT DOCUMENTS</b>   |  |                                |   |                          |          |                          |                          |
| EXAMINER'S<br>INITIALS  | PATENT NO.   | DATE                           | COUNTRY                                   | CLASS                    | SUBCLASS | TRANSLATION              |                          |
|   |  |                                |   |                          |          | YES                      | NO                       |
| SE  | ✓ EP 1 054 268 A   | 22 Nov<br>2000                 | Europe                                    | —                        | —        | <input type="checkbox"/> | <input type="checkbox"/> |
|   |  |                                |   |                          |          | <input type="checkbox"/> | <input type="checkbox"/> |
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|   |  |                                |   |                          |          | <input type="checkbox"/> | <input type="checkbox"/> |
| <b>OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)</b> |  |                                |   |                          |          |                          |                          |
| SE  | ✓ Lee et al., "A 3D X-ray Microtomographic system with CMOS Image Sensor", <u>Nuclear Science Symposium</u> , pp. 19.37-19.40 (XP002231401), Oct 15-20, 2000 |                                |   |                          |          |                          |                          |
|   |  |                                |   |                          |          |                          |                          |
|   |  |                                |   |                          |          |                          |                          |
|   |  |                                |   |                          |          |                          |                          |
| EXAMINER <i>Sh Lee</i>  |  |                                | DATE CONSIDERED 11/8/03                   |                          |          |                          |                          |

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